Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/630,846	HADLEY, MARC J.	
Examiner	Art Unit	
Djenane M. Bayard	2141	

	SEARCHED					
Class	Subclass	Date	Examiner			
709	203	12/30/2006	DB			
715	522	12/30/2006	. DB			
709	230	12/30/2006	DB			

INTERFERENCE SEARCHED		
Examiner		

SEARCH NOTES (INCLÚDING SEARCH STRATEGY)		
	DATE	EXMR
east	12/30/2006	DB
Inventor's search	12/30/2006	DB
Google scholar	12/30/2006	db
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